

# Search Notes



Application/Control No.

10/637,220

Examiner

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Applicant(s)/Patent under Reexamination

CARPENTER ET AL.

Art Unit

3637

## SEARCHED

Class	Subclass	Date	Examiner
106	55.3	3/14/00	04
	55.01		
	55.5		
	56.11		
	57.22		
	57.25		
250	346.01		
200	306		
	600		
	590	11/28/00	04

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Find Base Cir For Prior Art	3/14/00	04
<del>CRATED</del>	<del>11/28/00</del>	<del>04</del>